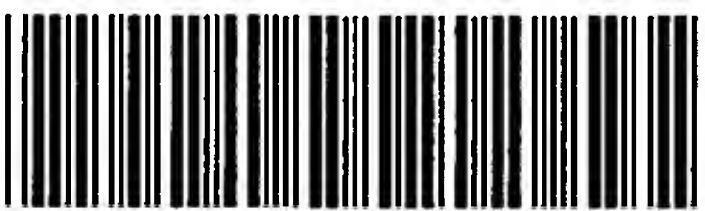


## **Search Notes**



**Application/Control No.**

10/604.530

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**Examiner**

F. Daniel Lopez

**Applicant(s)/Patent under  
Reexamination**

NAUMANN ET AL.

## Art Unit

3745

**SEARCHED**

# SEARCH NOTES (INCLUDING SEARCH STRATEGY)

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner